



PMV20XN

30 V, 4.8 A N-channel Trench MOSFET

Rev. 1 — 5 April 2011

Product data sheet

1. Product profile

1.1 General description

N-channel enhancement mode Field-Effect Transistor (FET) in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package using Trench MOSFET technology.

1.2 Features and benefits

- Low threshold voltage
- Very fast switching
- Trench MOSFET technology

1.3 Applications

- Relay driver
- High-speed line driver
- Low-side loadswitch
- Switching circuits

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j = 25^\circ\text{C}$	-	-	30	V
V_{GS}	gate-source voltage		-12	-	12	V
I_D	drain current	$V_{GS} = 4.5\text{ V}; T_{amb} = 25^\circ\text{C}$	[1]	-	-	A
Static characteristics						
R_{DSon}	drain-source on-state resistance	$V_{GS} = 4.5\text{ V}; I_D = 4.8\text{ A}; T_j = 25^\circ\text{C}$	-	19	25	$\text{m}\Omega$

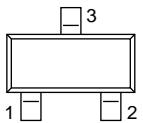
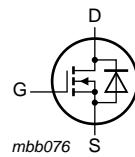
[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm².

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2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	S	source		
3	D	drain	 SOT23 (TO-236AB)	 <i>mbb076</i>

3. Ordering information

Table 3. Ordering information

Type number	Package	Version
Name	Description	
PMV20XN	TO-236AB	SOT23

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
PMV20XN	KW%

[1] % = placeholder for manufacturing site code

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5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j = 25^\circ\text{C}$	-	30	V
V_{GS}	gate-source voltage		-12	12	V
I_D	drain current	$V_{GS} = 4.5 \text{ V}; T_{amb} = 25^\circ\text{C}$	[1]	-	4.8 A
		$V_{GS} = 4.5 \text{ V}; T_{amb} = 100^\circ\text{C}$	[1]	-	3 A
I_{DM}	peak drain current	$T_{amb} = 25^\circ\text{C}$; single pulse; $t_p \leq 10 \mu\text{s}$	-	20	A
P_{tot}	total power dissipation	$T_{amb} = 25^\circ\text{C}$	[2]	-	510 mW
		$T_{sp} = 25^\circ\text{C}$	[1]	-	930 mW
			-	4170	mW
T_j	junction temperature		-55	150	°C
T_{amb}	ambient temperature		-55	150	°C
T_{stg}	storage temperature		-65	150	°C
Source-drain diode					
I_S	source current	$T_{amb} = 25^\circ\text{C}$	[1]	-	1 A

[1] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated, mounting pad for drain 6 cm².

[2] Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	[1]	-	207	K/W
			[2]	-	116	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	20	30	K/W

[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.

[2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 6 cm².

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7. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu\text{A}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$	30	-	-	V
V_{GSth}	gate-source threshold voltage	$I_D = 250 \mu\text{A}; V_{DS} = V_{GS}; T_j = 25^\circ\text{C}$	0.5	1	1.5	V
I_{DSS}	drain leakage current	$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$	-	-	1	μA
		$V_{DS} = 30 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150^\circ\text{C}$	-	-	20	μA
I_{GSS}	gate leakage current	$V_{GS} = 12 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25^\circ\text{C}$	-	-	100	nA
		$V_{GS} = -12 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25^\circ\text{C}$	-	-	100	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 4.5 \text{ V}; I_D = 4.8 \text{ A}; T_j = 25^\circ\text{C}$	-	19	25	$\text{m}\Omega$
		$V_{GS} = 4.5 \text{ V}; I_D = 4.8 \text{ A}; T_j = 150^\circ\text{C}$	-	31	40	$\text{m}\Omega$
		$V_{GS} = 2.5 \text{ V}; I_D = 4 \text{ A}; T_j = 25^\circ\text{C}$	-	26	35	$\text{m}\Omega$
g_{fs}	forward transconductance	$V_{DS} = 5 \text{ V}; I_D = 3 \text{ A}; T_j = 25^\circ\text{C}$	-	8	-	S
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 3 \text{ A}; V_{DS} = 15 \text{ V}; V_{GS} = 4.5 \text{ V}; T_j = 25^\circ\text{C}$	-	6.4	10	nC
Q_{GS}	gate-source charge		-	1.8	-	nC
Q_{GD}	gate-drain charge		-	1.1	-	nC
C_{iss}	input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 15 \text{ V}; f = 1 \text{ MHz}; T_j = 25^\circ\text{C}$	-	585	-	pF
C_{oss}	output capacitance		-	110	-	pF
C_{rss}	reverse transfer capacitance		-	55	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 15 \text{ V}; V_{GS} = 5.4 \text{ V}; R_{G(ext)} = 6 \Omega; T_j = 25^\circ\text{C}; I_D = 4.8 \text{ A}$	-	12	-	ns
t_r	rise time		-	27	-	ns
$t_{d(off)}$	turn-off delay time		-	128	-	ns
t_f	fall time		-	68	-	ns
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 1 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$	-	0.75	1.2	V